Reply under 37 C.F.R. 1.116 Expedited Procedure Technology Center 2823

Lo No. Carren

Confirmation No. 6408

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant:

Meunier-Beillard et al.

Examiner:

Khiem Nguyen

Serial No.:

10/550,853

Group Art Unit:

2823

Filed:

September 22, 2005

Docket No.:

NL030357 US1

Title:

METHOD OF EPITAXIAL DEPOSITION OF AN N-DOPED SILICON

LAYER

FINAL OFFICE ACTION RESPONSE

Mail Stop AF Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Customer No. 65913

Dear Sir:

In response to the final Office Action dated September 17, 2007, please reconsider the application in view of the following amendments and remarks.

A complete listing of the claims, to include any amendments presented therein, begins on page 2 of this paper.

Remarks/Arguments follow on page 5.

Authorization is provided to charge/credit Deposit Account 50-0996 (NXPS.265PA) any requisite fees/overages to enter this paper.